

## **MOSFET**

### OptiMOS<sup>™</sup> 3 Power-Transistor, 200 V

#### **Features**

- N-channel, normal level
- Very low on-resistance R<sub>DS(on)</sub>
   Fast diode (FD) with reduced Q<sub>rr</sub>
- 175°C operating temperature

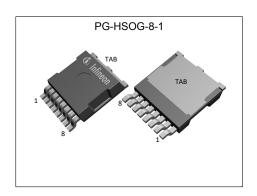
- Pb-free lead plating; RoHS compliant
  Halogen-free according to IEC61249-2-21
  Optimized for hard commutation ruggedness

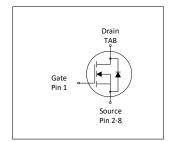
#### **Product validation**

Fully qualified according to JEDEC for Industrial Applications

Table 1 **Key Performance Parameters** 

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Parameter	Value	Unit					
$V_{ t DS}$	200	V					
$R_{ extsf{DS(on),max}}$	11.1	mΩ					
I <sub>D</sub>	108	A					
Qoss	162	nC					
Q <sub>G</sub>	65	nC					











Type / Ordering Code Package		Marking	Related Links
IPTG111N20NM3FD	PG-HSOG-8-1	111N20NF	-

# OptiMOS<sup>TM</sup> 3 Power-Transistor, 200 V IPTG111N20NM3FD



Rev. 2.0, 2021-02-11

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## OptiMOS<sup>™</sup> 3 Power-Transistor, 200 V IPTG111N20NM3FD



# 1 Maximum ratings at $T_A$ =25 °C, unless otherwise specified

Table 2 Maximum ratings

Davis and an	C. mah al	Values				
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	- - -	-	108 76 10.8	A	$V_{GS}$ =10 V, $T_{C}$ =25 °C $V_{GS}$ =10 V, $T_{C}$ =100 °C $V_{GS}$ =10 V, $T_{A}$ =25 °C, $R_{THJA}$ =40 °C/W <sup>2)</sup>
Pulsed drain current <sup>3)</sup>	I <sub>D,pulse</sub>	-	-	432	Α	<i>T</i> <sub>A</sub> =25 °C
Avalanche energy, single pulse <sup>4)</sup>	<b>E</b> AS	-	-	375	mJ	$I_{\rm D}$ =67 A, $R_{\rm GS}$ =25 $\Omega$
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-
Power dissipation	P <sub>tot</sub>	-	-	375 3.8	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>THJA</sub> =40 °C/W <sup>2)</sup>
Operating and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56

#### 2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
raiailletei	Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	0.4	K/W	-
Thermal resistance, junction - ambient, 6 cm² cooling area	R <sub>thJA</sub>	-	-	40	K/W	-
Thermal resistance, junction - ambient, minimal footprint $^{2)}$	R <sub>thJA</sub>	_	-	62	K/W	-

<sup>&</sup>lt;sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.  $^{2)}$  Device on 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^{2}$  (one layer, 70  $\mu$ m thick) copper area for drain

connection. PCB is vertical in still air.

3) See Diagram 3 for more detailed information

<sup>&</sup>lt;sup>4)</sup> See Diagram 13 for more detailed information

## OptiMOS<sup>™</sup> 3 Power-Transistor, 200 V . IPTG111N20NM3FD



# 3 Electrical characteristics at $T_j$ =25 °C, unless otherwise specified

**Static characteristics** Table 4

			Value	s			
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	200	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	
Gate threshold voltage	V <sub>GS(th)</sub>	2	3	4	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =267 μA	
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.1 10	1 100	μA	V <sub>DS</sub> =160 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C V <sub>DS</sub> =160 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C	
Gate-source leakage current	$I_{\mathrm{GSS}}$	-	1	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	9.0	11.1	mΩ	V <sub>GS</sub> =10 V, I <sub>D</sub> =96 A	
Gate resistance <sup>1)</sup>	R <sub>G</sub>	-	2.8	4.2	Ω	-	
Transconductance	<b>g</b> fs	82	160	-	S	V <sub>DS</sub>  ≥2  I <sub>D</sub>   R <sub>DS(on)max</sub> , I <sub>D</sub> =96 A	

Table 5 **Dynamic characteristics** 

Developeday	Sumah a l		Values			
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance <sup>1)</sup>	Ciss	-	5300	7000	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =100 V, <i>f</i> =1 MHz
Output capacitance <sup>1)</sup>	Coss	-	400	520	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =100 V, f=1 MHz
Reverse transfer capacitance <sup>1)</sup>	C <sub>rss</sub>	_	6	11	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =100 V, f=1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	13	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =48 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Rise time	t <sub>r</sub>	-	11	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =48 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Turn-off delay time	$t_{ m d(off)}$	-	39	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =48 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Fall time	t <sub>f</sub>	-	13	-	ns	$V_{\rm DD}$ =100 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =48 A, $R_{\rm G,ext}$ =1.6 $\Omega$

Table 6 Gate charge characteristics<sup>2)</sup>

Parameter	Symbol	Values			Linit	Note / Test Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	<b>Q</b> gs	-	25	-	nC	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =96 A, $V_{\rm GS}$ =0 to 10 V
Gate charge at threshold	$Q_{g(th)}$	-	16	-	nC	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =96 A, $V_{\rm GS}$ =0 to 10 V
Gate to drain charge <sup>1)</sup>	$Q_{ m gd}$	-	8.2	12.3	nC	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =96 A, $V_{\rm GS}$ =0 to 10 V
Switching charge	Q <sub>sw</sub>	-	17.4	-	nC	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =96 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total <sup>1)</sup>	$Q_g$	-	65	81	nC	$V_{\rm DD}$ =100 V, $I_{\rm D}$ =96 A, $V_{\rm GS}$ =0 to 10 V
Gate plateau voltage	V <sub>plateau</sub>	-	4.7	-	V	$V_{DD}$ =100 V, $I_{D}$ =96 A, $V_{GS}$ =0 to 10 V
Output charge <sup>1)</sup>	Qoss	-	162	215	nC	V <sub>DS</sub> =100 V, V <sub>GS</sub> =0 V

 $<sup>^{1)}</sup>$  Defined by design. Not subject to production test.  $^{2)}$  See "Gate charge waveforms" for parameter definition

# OptiMOS<sup>TM</sup> 3 Power-Transistor, 200 V IPTG111N20NM3FD

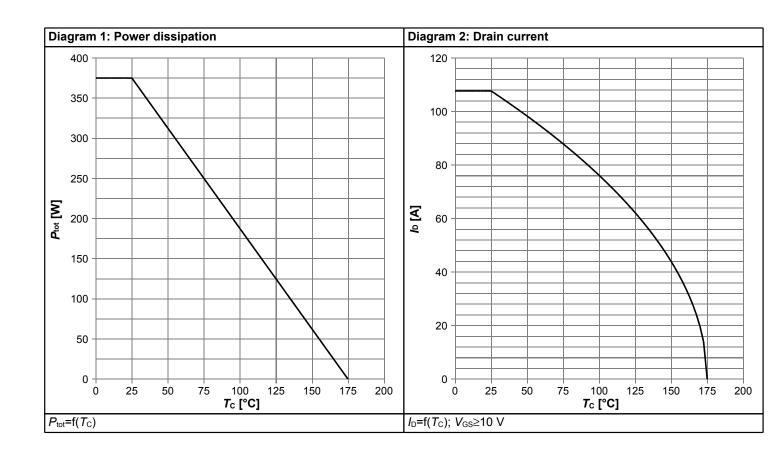


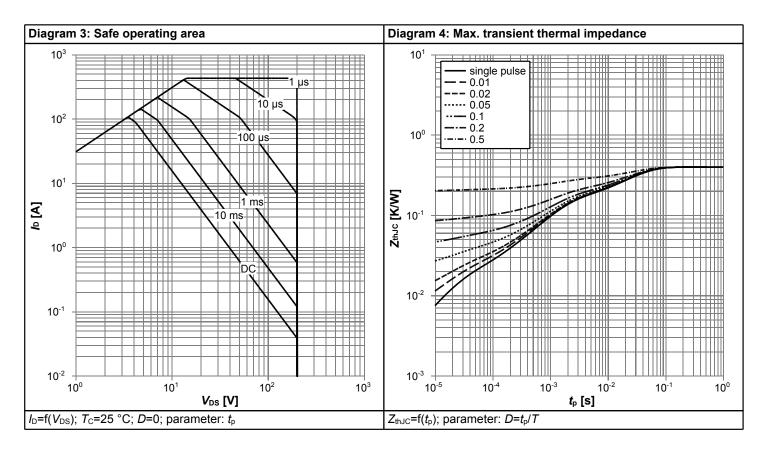
#### Table 7 Reverse diode

Parameter	Cumbal		Values			Nata / Tank Oam dition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current	Is	-	-	108	Α	<i>T</i> <sub>C</sub> =25 °C
Diode pulse current	I <sub>S,pulse</sub>	-	-	432	Α	<i>T</i> <sub>C</sub> =25 °C
Diode forward voltage	V <sub>SD</sub>	-	0.95	1.2	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =96 A, T <sub>j</sub> =25 °C
Reverse recovery time <sup>1)</sup>	t <sub>rr</sub>	-	125	250	ns	V <sub>R</sub> =100 V, I <sub>F</sub> =96 A, d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/μs
Reverse recovery charge <sup>1)</sup>	Qrr	-	309	-	nC	V <sub>R</sub> =100 V, I <sub>F</sub> =96 A, di <sub>F</sub> /dt=100 A/μs

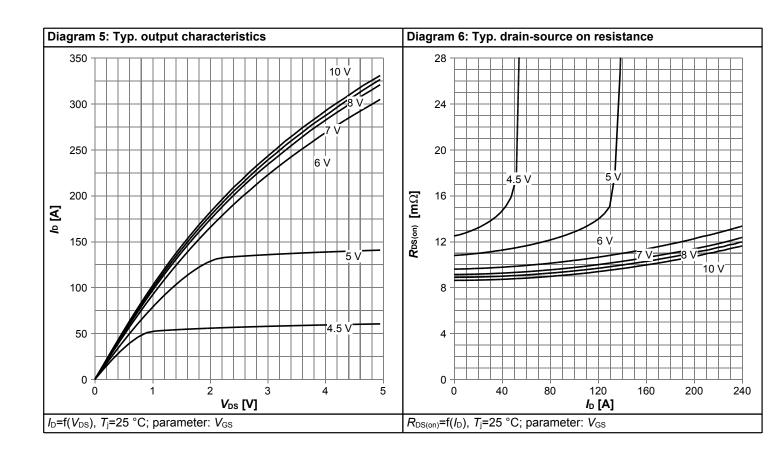


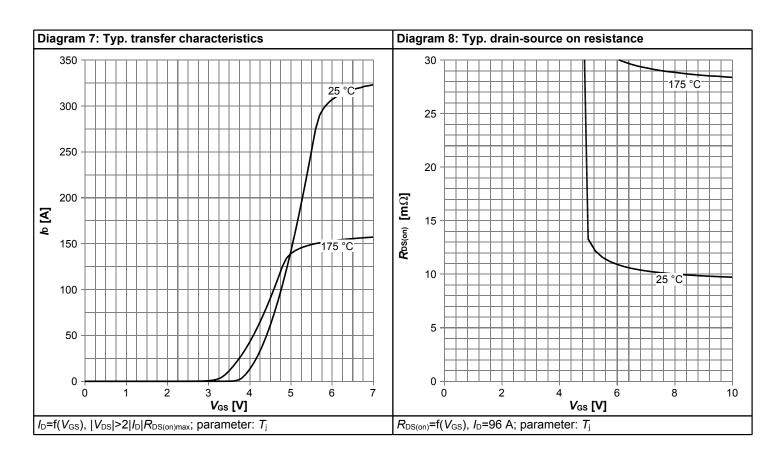
### 4 Electrical characteristics diagrams



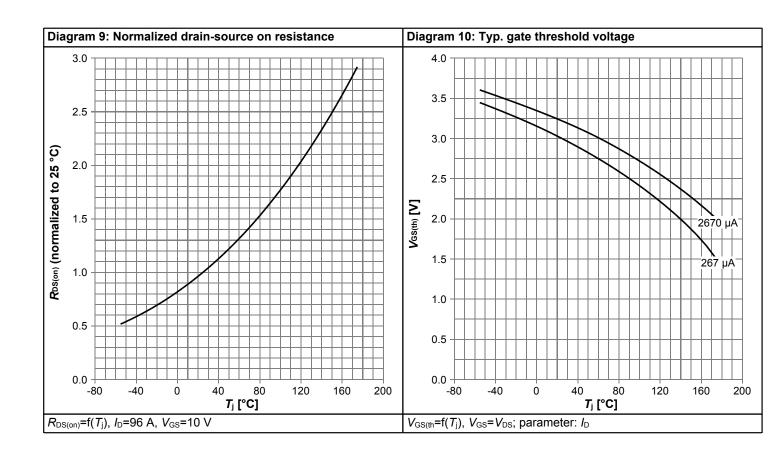


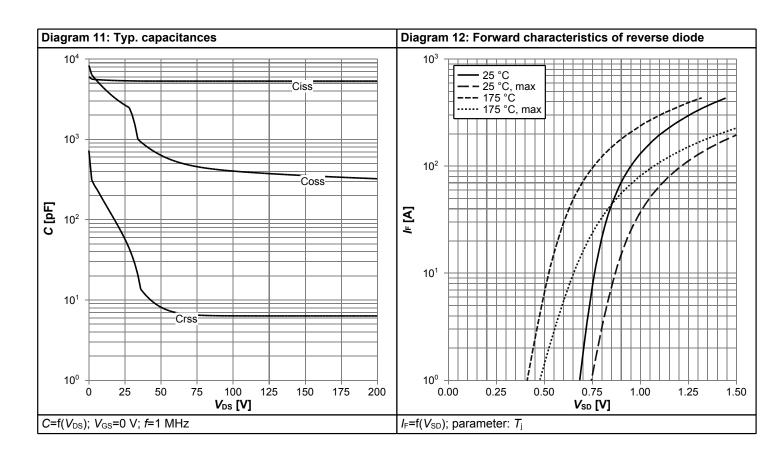




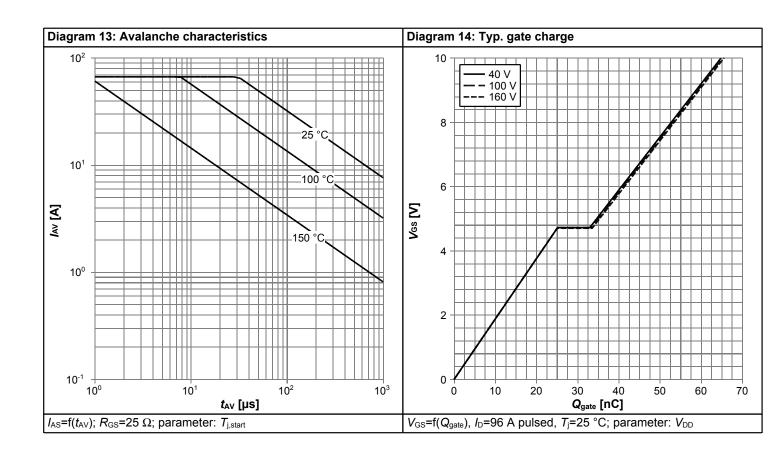


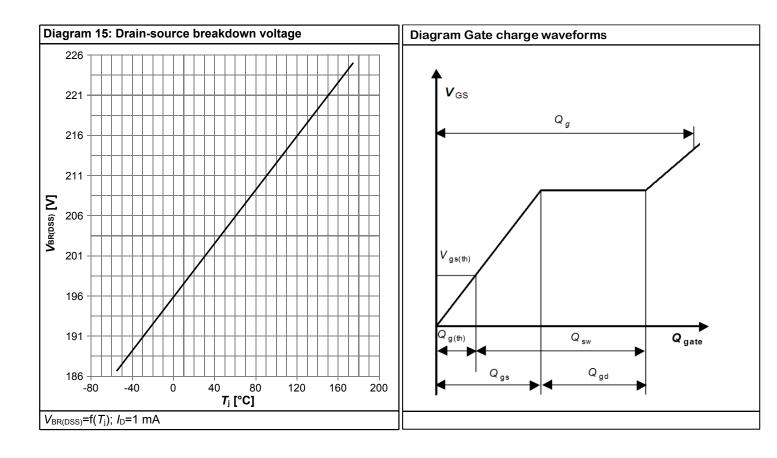






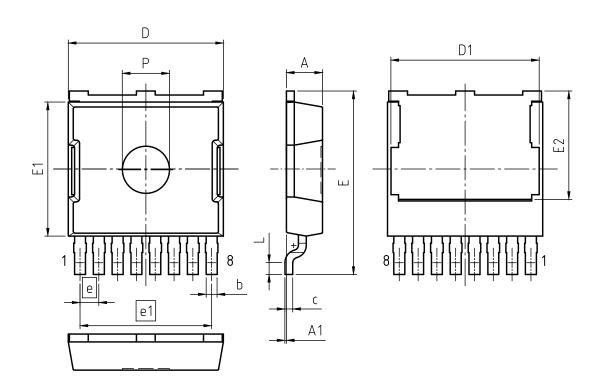








# 5 Package Outlines



PACKAGE - GROUP NUMBER:	PG-HSC	PG-HSOG-8-U01			
REVISION: 01	DATE	: 08.02.2021			
DIMENSIONS	MILLIN	IETERS			
DIVIENSIONS	MIN.	MAX.			
Α	2.20	2.40			
A1	0.00	0.10			
b	0.60	0.80			
С	0.40	0.60			
D	9.70	10.10			
D1	9.36	9.56			
E	11.50	11.90			
E1	8.45	8.75			
E2	6.81	7.01			
е	1.20				
e1	8.	.40			
L	0.66	0.86			
P	2.90	3.10			

Figure 1 Outline PG-HSOG-8-1, dimensions in mm

# OptiMOS<sup>TM</sup> 3 Power-Transistor, 200 V IPTG111N20NM3FD



#### **Revision History**

IPTG111N20NM3FD

Revision: 2021-02-11, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)			
2.0	2021-02-11	Release of final version			

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